

Corrigendum: High yield and ultrafast sources of electrically triggered entangled-photon pairs based on strain-tunable quantum dots

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This Article contains errors in the labelling of the ticks of the x axis in Fig. 5. In panel a, the x axis values should have been labelled ‘ -10 ns’ and ‘ 10 ns’ rather than ‘ -5 ns’ and ‘ 5 ns’. In panels b and c, the x axis values should have been labelled ‘ -25 ns’ and ‘ 25 ns’ rather than ‘ -10 ns’ and ‘ 10 ns’. The correct version of this figure appears below.

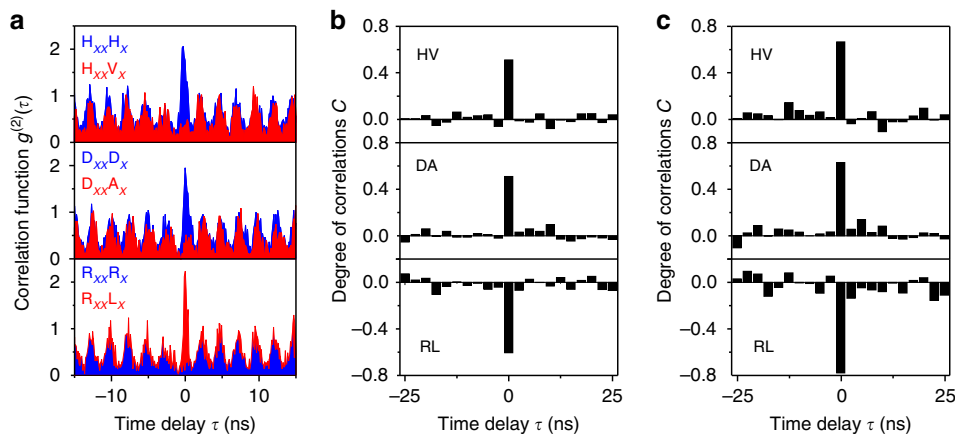


Figure 5 | Polarization correlation results from the ST-ELED under electrically pulsed injection at repetition rate of 400 MHz. (a) Normalized correlation functions for co- and cross-polarized XX and X photons in HV, DA and RL bases. (b,c) Degree of correlation C in given basis, in which correlation in HV and DA bases ($C > 0$) and anti-correlation ($C < 0$) in RL basis are obtained without temporal gate ($\Delta\tau = 2.5$ ns) and with a temporal gate width $\Delta\tau = 0.8$ ns centred at 0 delay time, respectively.



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